

**Notice of References Cited**

Application/Control No.

10/599,540

Applicant(s)/Patent Under  
Reexamination  
OKEYA, SHIGEO

Examiner

/Yonel Beaulieu/

Art Unit

3661

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,471,955	12-2008	Muramatsu, Toshihiko	455/456.6
*	B	US-7,539,574	05-2009	Takashima et al.	701/208
*	C	US-7,302,342	11-2007	Kobayashi et al.	701/207
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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